

Search Notes

Application/Control No.

10/501,888

Examiner

J. Pasterczyk

Applicant(s)/Patent and Reexamination

MATSUNAGA ET AL.

Art Unit

1755

SEARCHED

Class	Subclass	Date	Examiner
502	104 110	6/05	
	126		
	129		
	132-134		
	169		
	172		
526	124.9		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner